LISTING OF THE CLAIMS

(currently amended) An insulated integrated circuit comprising:
 an [[An]] integrated circuit; and

<u>an</u> [[An]] insulating layer having a dielectric constant of less than about 2.5 is disposed on said integrated circuit, wherein said insulating layer is a polyimide film that is the polymerization product of polymerization product of an aromatic diamine having the general formula (I):

$$\mathsf{H_2N} - \bigvee_{\mathsf{F_3C}} \mathsf{CF_3} \\ \mathsf{F_3C}$$

and an aromatic dianhydride having the formula (II):

wherein R is an organic substituent selected from the group consisting of CF₃, o-trifluoromethyl phenyl, m-trifluoromethyl phenyl, p-trifluoromethyl phenyl and 3,5 bis[(m-trifluoromethyl) phenyl]; or

the polymerization product of an ermatic aromatic dianhydride having the general formula (III):

and an aromatic diamine having the formula (IV):

$$H_2N$$
 R
 NH_2

wherein R is a substituent selected from the group consisting of trifluoromethyl, o-trifluoromethyl phenyl, m-trifluoromethyl phenyl, p-trifluoromethyl phenyl and 3,5'-bis[(m-trifluoromethyl) phenyl] further wherein the dielectric constant of said insulating layer is less than about 2.—5.

- 2. (original) The insulated integrated circuit according to claim 1, wherein said integrated circuit is a microprocessor.
- 3. (original) The insulated integrated circuit according to claim 1, wherein the thickness of said insulating layer is from about 10 to about 1000 microns.

- 4. (original) The insulated integrated circuit according to claim 1, wherein the thickness of said insulating layer is from about 10 to about 500 microns.
- 5. (original) The insulated integrated circuit according to claim 1, wherein the thickness of said insulating layer is from about 10 to about 100 microns.
 - 6. (canceled)
 - 7. (canceled)
 - 8. (canceled)
- 9. (original) The insulated integrated circuit according to claim 1, wherein the coefficient of thermal expansion is greater than about 23x10⁻⁶/°C.
- 10. (original) The insulated integrated circuit according to claim 1, wherein the coefficient of thermal expansion is greater than about 42×10^{-6} C.
- 11. (original) The insulated integrated circuit according to claim 1, wherein the coefficient of thermal expansion is greater than about 50x10⁻⁶/°C.
- 12. (currently amended) An insulated electrically conductive component comprising:

an electrically conductive component; and

an insulating layer comprising the polylmerization product of an aromatic diamine having the general formula (I):

$$H_2N$$
 F_3C
 CF_3
 NH_2

and an aromatic dianhydride having the formula (II):

wherein R is an organic substituent selected from the group consisting of CF₃, o-trifluoromethyl phenyl, m-trifluoromethyl phenyl, p-trifluoromethyl phenyl and 3,5-bis[(m-trifluoromethyl) phenyl]; or

the polymerization product of an aromatic dianhydride having the general formula (III):

and an aromatic diamine having the formula (IV):

$$H_2N$$
 R
 R
 R

wherein R is a substituent selected from the group consisting of trifluoromethyl, o-trifluoromethyl phenyl, m-trifluoromethyl phenyl, p-trifluoromethyl phenyl and 3,5'-bis[(m-trifluoromethyl) phenyl], and wherein the coefficient of thermal expansion of the insulated electrically conductive component is greater than about 23x10⁻⁶/°C.

- 13. (previously presented) The insulated electrically conductive component according to claim 12, wherein said electrically conductive component is selected from the group consisting of capacitors, diodes, connectors and transistors.
- 14. (original) The insulated electrically conductive component according to claim 12, wherein the thickness of said insulating layer is from about 10 to about 1000 microns.
- 15. (original) The insulated electrically conductive component according to claim 12, wherein the thickness of said insulating layer is from about 10 to about 500 microns.
- 16. (original) The insulated electrically conductive component according to claim 12, wherein the thickness of said insulating layer is from about 10 to about 100 microns.

- 17. (original) The insulated electrically conductive component according to claim 12, wherein the dielectric constant of said insulating layer is less than about 2.8.
- 18. (original) The insulated electrically conductive component according to claim 12, wherein the dielectric constant of said insulating layer is less than about 2.7.
- 19. (original) The insulated electrically conductive component according to claim 12, wherein the dielectric constant of said insulating layer is less than about 2.5.
 - 20. (canceled)
- 21. (original) The insulated electrically conductive component according to claim 12, wherein the coefficient of thermal expansion is greater than about 42x10⁻⁸/°C.
- 22. (original) The insulated electrically conductive component according to claim 1, wherein the coefficient of thermal expansion is greater than about 50x10⁻⁶/°C.
 - 23. (canceled)
 - 24. (canceled)
 - 25. (canceled).